



May 2000

QFET™

# FQPF5N30

## 300V N-Channel MOSFET

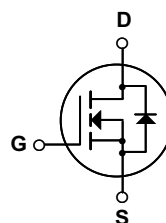
### General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supply.

### Features

- 3.9A, 300V,  $R_{DS(on)} = 0.9\Omega$  @  $V_{GS} = 10V$
- Low gate charge ( typical 9.8 nC)
- Low  $C_{rss}$  ( typical 9.5 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

| Symbol         | Parameter                                                                     | FQPF5N30    | Units               |
|----------------|-------------------------------------------------------------------------------|-------------|---------------------|
| $V_{DSS}$      | Drain-Source Voltage                                                          | 300         | V                   |
| $I_D$          | Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )                       | 3.9         | A                   |
|                | - Continuous ( $T_C = 100^\circ\text{C}$ )                                    | 2.47        | A                   |
| $I_{DM}$       | Drain Current - Pulsed (Note 1)                                               | 15.6        | A                   |
| $V_{GSS}$      | Gate-Source Voltage                                                           | $\pm 30$    | V                   |
| $E_{AS}$       | Single Pulsed Avalanche Energy (Note 2)                                       | 340         | mJ                  |
| $I_{AR}$       | Avalanche Current (Note 1)                                                    | 3.9         | A                   |
| $E_{AR}$       | Repetitive Avalanche Energy (Note 1)                                          | 3.5         | mJ                  |
| dv/dt          | Peak Diode Recovery dv/dt (Note 3)                                            | 4.5         | V/ns                |
| $P_D$          | Power Dissipation ( $T_C = 25^\circ\text{C}$ )                                | 35          | W                   |
|                | - Derate above $25^\circ\text{C}$                                             | 0.28        | W/ $^\circ\text{C}$ |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range                                       | -55 to +150 | $^\circ\text{C}$    |
| $T_L$          | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300         | $^\circ\text{C}$    |

### Thermal Characteristics

| Symbol          | Parameter                               | Typ | Max  | Units                     |
|-----------------|-----------------------------------------|-----|------|---------------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case    | --  | 3.57 | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | --  | 62.5 | $^\circ\text{C}/\text{W}$ |

**Electrical Characteristics** $T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

**Off Characteristics**

|                                |                                           |                                                                   |     |      |      |                     |
|--------------------------------|-------------------------------------------|-------------------------------------------------------------------|-----|------|------|---------------------|
| $BV_{DSS}$                     | Drain-Source Breakdown Voltage            | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$               | 300 | --   | --   | V                   |
| $\Delta BV_{DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$ , Referenced to $25^\circ\text{C}$ | --  | 0.26 | --   | V/ $^\circ\text{C}$ |
| $I_{DSS}$                      | Zero Gate Voltage Drain Current           | $V_{DS} = 300\text{ V}, V_{GS} = 0\text{ V}$                      | --  | --   | 1    | $\mu\text{A}$       |
|                                |                                           | $V_{DS} = 240\text{ V}, T_C = 125^\circ\text{C}$                  | --  | --   | 10   | $\mu\text{A}$       |
| $I_{GSSF}$                     | Gate-Body Leakage Current, Forward        | $V_{GS} = 30\text{ V}, V_{DS} = 0\text{ V}$                       | --  | --   | 100  | nA                  |
| $I_{GSSR}$                     | Gate-Body Leakage Current, Reverse        | $V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$                      | --  | --   | -100 | nA                  |

**On Characteristics**

|              |                                   |                                                      |     |      |     |          |
|--------------|-----------------------------------|------------------------------------------------------|-----|------|-----|----------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$      | 3.0 | --   | 5.0 | V        |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS} = 10\text{ V}, I_D = 1.95\text{ A}$          | --  | 0.68 | 0.9 | $\Omega$ |
| $g_{FS}$     | Forward Transconductance          | $V_{DS} = 50\text{ V}, I_D = 1.95\text{ A}$ (Note 4) | --  | 2.7  | --  | S        |

**Dynamic Characteristics**

|           |                              |                                                                      |    |     |     |    |
|-----------|------------------------------|----------------------------------------------------------------------|----|-----|-----|----|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1.0\text{ MHz}$ | -- | 330 | 430 | pF |
| $C_{oss}$ | Output Capacitance           |                                                                      | -- | 70  | 90  | pF |
| $C_{rss}$ | Reverse Transfer Capacitance |                                                                      | -- | 9.5 | 13  | pF |

**Switching Characteristics**

|              |                     |                                                                                             |    |     |     |    |
|--------------|---------------------|---------------------------------------------------------------------------------------------|----|-----|-----|----|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD} = 150\text{ V}, I_D = 5.4\text{ A},$<br>$R_G = 25\text{ }\Omega$<br><br>(Note 4, 5) | -- | 11  | 32  | ns |
| $t_r$        | Turn-On Rise Time   |                                                                                             | -- | 55  | 120 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |                                                                                             | -- | 17  | 45  | ns |
| $t_f$        | Turn-Off Fall Time  |                                                                                             | -- | 27  | 65  | ns |
| $Q_g$        | Total Gate Charge   | $V_{DS} = 240\text{ V}, I_D = 5.4\text{ A},$<br>$V_{GS} = 10\text{ V}$<br><br>(Note 4, 5)   | -- | 9.8 | 13  | nC |
| $Q_{gs}$     | Gate-Source Charge  |                                                                                             | -- | 2.4 | --  | nC |
| $Q_{gd}$     | Gate-Drain Charge   |                                                                                             | -- | 5.1 | --  | nC |

**Drain-Source Diode Characteristics and Maximum Ratings**

|                 |                                                       |                                                                                            |    |     |      |    |
|-----------------|-------------------------------------------------------|--------------------------------------------------------------------------------------------|----|-----|------|----|
| I <sub>S</sub>  | Maximum Continuous Drain-Source Diode Forward Current |                                                                                            | -- | --  | 3.9  | A  |
| I <sub>SM</sub> | Maximum Pulsed Drain-Source Diode Forward Current     |                                                                                            | -- | --  | 15.6 | A  |
| V <sub>SD</sub> | Drain-Source Diode Forward Voltage                    | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 3.9 A                                              | -- | --  | 1.5  | V  |
| t <sub>rr</sub> | Reverse Recovery Time                                 | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 5.4 A,<br>dI <sub>F</sub> / dt = 100 A/μs (Note 4) | -- | 130 | --   | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge                               |                                                                                            | -- | 0.6 | --   | μC |

**Notes:**

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $L = 37.3\text{ mH}, I_{AS} = 3.9\text{ A}, V_{DD} = 50\text{ V}, R_G = 25\text{ }\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 5.4\text{ A}, di/dt \leq 200\text{ A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$
5. Essentially independent of operating temperature

# Typical Characteristics

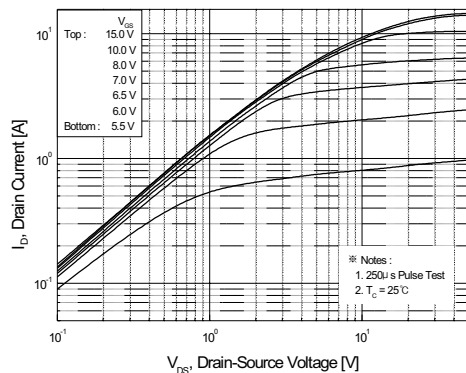


Figure 1. On-Region Characteristics

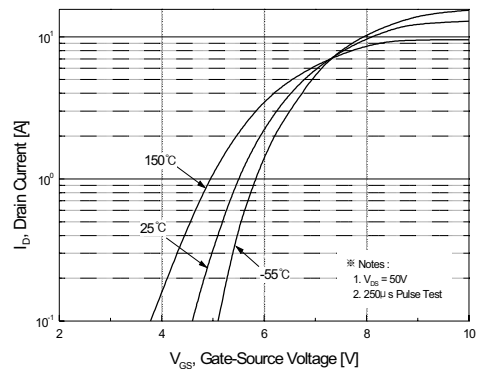


Figure 2. Transfer Characteristics

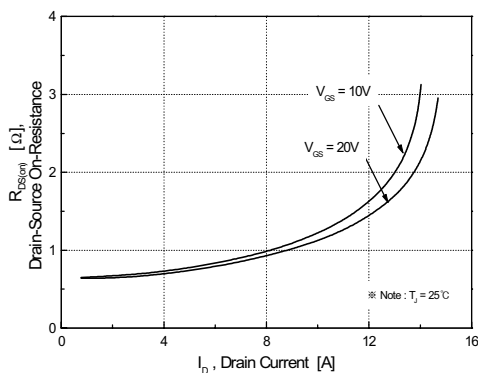


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

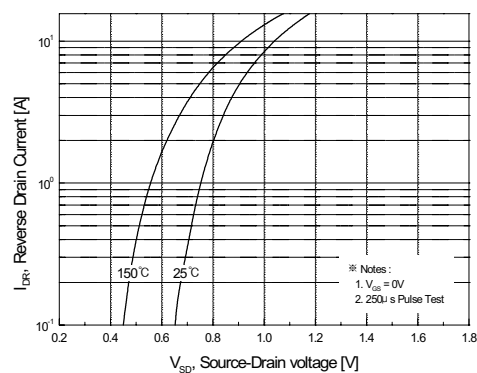


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

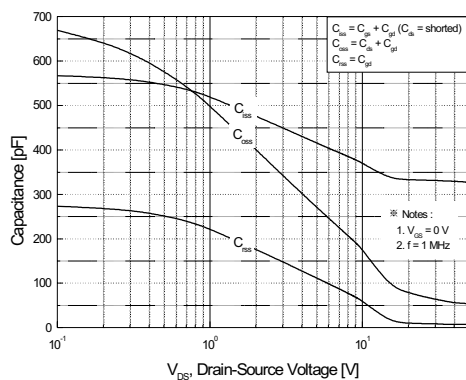


Figure 5. Capacitance Characteristics

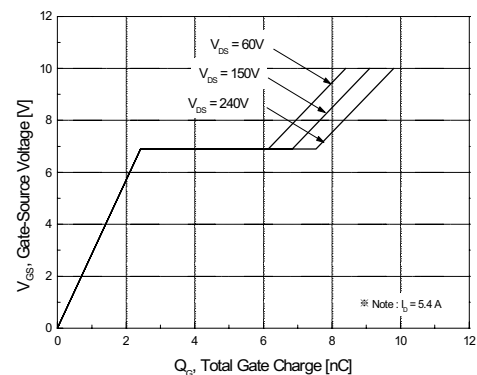


Figure 6. Gate Charge Characteristics

# Typical Characteristics (Continued)

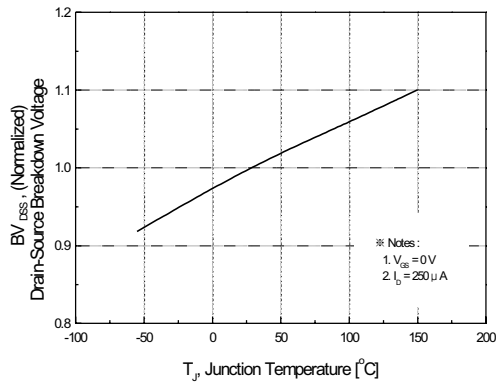


Figure 7. Breakdown Voltage Variation vs. Temperature

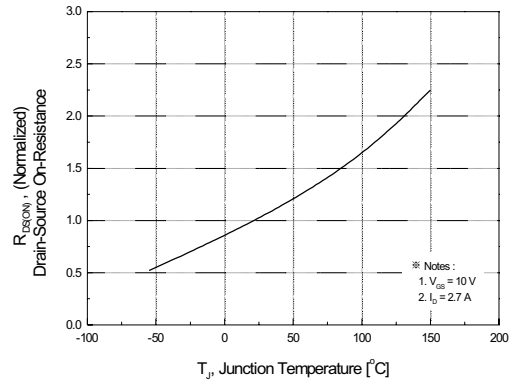


Figure 8. On-Resistance Variation vs. Temperature

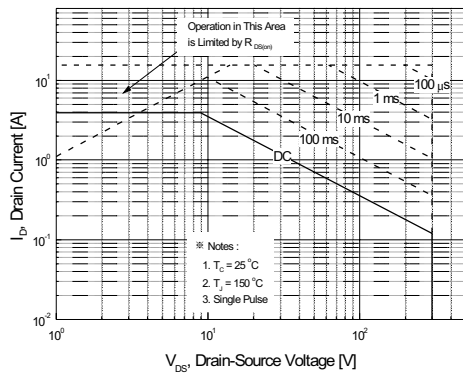


Figure 9. Maximum Safe Operating Area

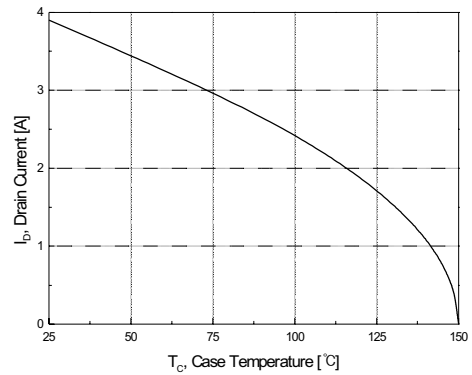


Figure 10. Maximum Drain Current vs. Case Temperature

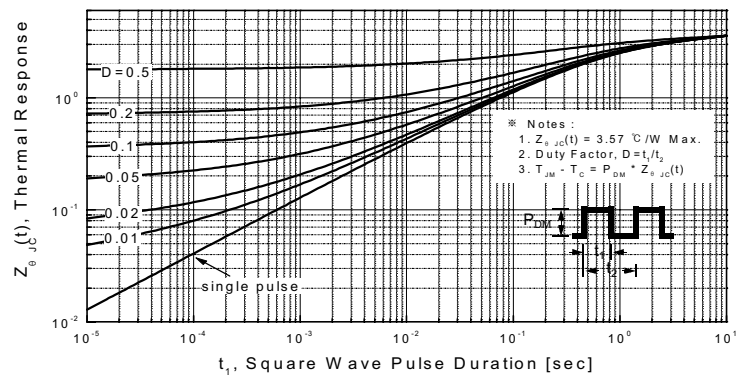


Figure 11. Transient Thermal Response Curve

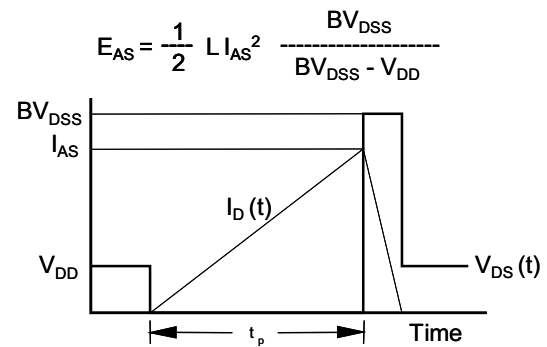
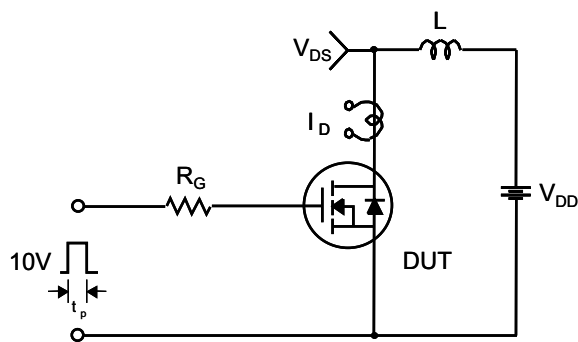
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms

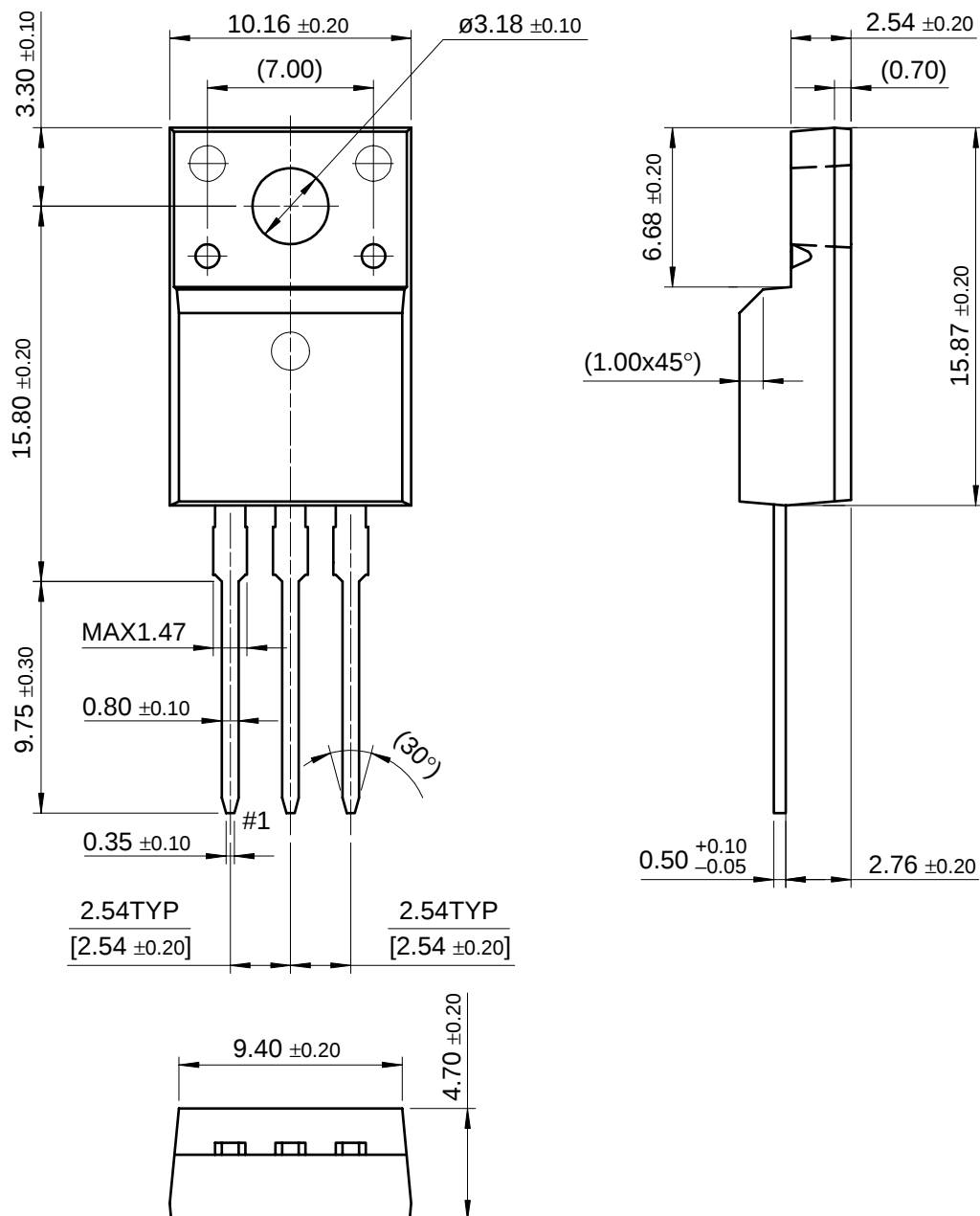


# Peak Diode Recovery dv/dt Test Circuit & Waveforms



## Package Dimensions

## TO-220F



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| CROSSVOLT™           | POP™          | UHC™        |
| E <sup>2</sup> CMOS™ | PowerTrench®  | VCX™        |
| FACT™                | QFET™         |             |
| FACT Quiet Series™   | QS™           |             |
| FAST®                | Quiet Series™ |             |
| FAST <sup>r</sup> ™  | SuperSOT™-3   |             |
| GTO™                 | SuperSOT™-6   |             |

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